Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10823548	LEE ET AL.
Examiner	**Art Unit**
IAN JEN	3664

ORIGINAL

CLASS	SUBCLASS
700	245

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
701	300	23	24	25	41
700	258	259			
318	568.1	568.12	568.16	568.17	
340	636.15	636.2			
414	227				

INTERNATIONAL CLASSIFICATION

CLAIMED	NON-CLAIMED
G 06F 19 / 00 (2006.01.01)	G 05B 15 / 00 (2006.01.01)
	B 25J 9 / 16 (2006.01.01)
	B 25J 5 / 00 (2006.01.01)
	G 08B 21 / 00 (2006.01.01)
	E 04H 6 / 00 (2006.01.01)

☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47

Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
1	1	17	17	-	33										
2	2	18	18	-	34										
3	3	19	19	-	35										
4	4	20	20	-	36										
5	5	21	21	-	37										
6	6	22	22	-	38										
7	7	23	23	-	39										
8	8	24	24	-	40										
9	9	25	25	27	41										
10	10	26	26												
11	11	-	27												
12	12	-	28												
13	13	-	29												
14	14	-	30												
15	15	-	31												
16	16	-	32												

/IAN JEN/ Examiner.Art Unit 3664 (Assistant Examiner)	01/09/2009 (Date)	**Total Claims Allowed:** 27	
/Dalena Tran/ Primary Examiner.Art Unit 3664 (Primary Examiner)	01/30/2009 (Date)	O.G. Print Claim(s) 1	O.G. Print Figure 1